

## 阅读申明

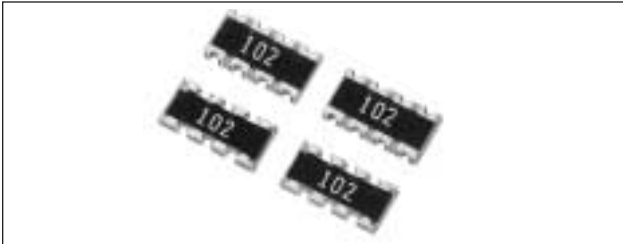
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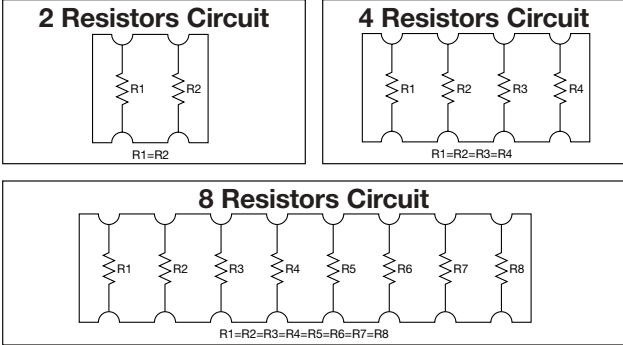
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# Chip Resistor Arrays

## CRB Series (Concave Type)



Chip Resistor Arrays have several resistor elements integrated as a single component.



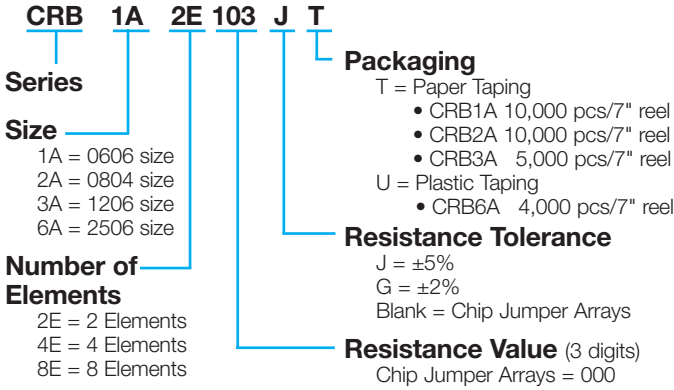
### FEATURES

- Reduction in mounting process & costs
- Save PCB space
- Reduction of inventory control costs

### APPLICATIONS

- Computer
- Hard Disk Drive
- Printer
- CD-ROM

### HOW TO ORDER



### RATING

Chip Resistor Arrays	
Item	Rating
Rated Power (70°C)*	1/16W Element
Max. Working Voltage	50V
Max. Overload Voltage	100V
Resistance Value	10Ω to 2.2MΩ (CRB6A 1MΩ max.)
Tolerance	J±5% (CRB6A G ± 2% only)
Working Temperature	-55 to +125°C

Chip Jumper Arrays	
Item	Rating
Rated Current	1A
Conductive Resistance Value	50MΩ max.
Resistance Value	Zero ohms (0 ± .5 ohms)
Working Temperature	-55 to +125°C

\*Rated voltage = 50V or  $\sqrt{\text{Rated power} \times \text{Resistance value}}$ , whichever is less

### DIMENSIONS

millimeters (inches)

Code	W	L	C	d	t	a	b	P
Dim.	1.60±0.15 (0.063±0.006)	1.60±0.20 (0.063±0.008)	0.30±0.20 (0.012±0.008)	0.40±0.15 (0.016±0.006)	0.60±0.10 (0.024±0.006)	0.50±0.15 (0.020±0.006)	0.30±0.10 (0.012±0.004)	0.80±0.10 (0.031±0.004)
No Marking on chips								

Code	L	W	T	P	b	c	d	e
Dim.	2.00±0.10 (0.079±0.004)	1.00±0.10 (0.039±0.004)	0.40±0.10 (0.016±0.004)	0.50 typ (0.020 typ)	∅0.15 typ (∅0.006 typ)	0.20±0.15 (0.008±0.006)	0.25±0.015 (0.010±0.006)	0.25 typ (0.010 typ)

Code	W	L	C	D	T	P
Dim.	1.60±0.15 (0.063±0.006)	3.20±0.15 (0.126±0.006)	0.30±0.20 (0.012±0.008)	0.40±0.15 (0.016±0.006)	0.60±0.10 (0.024±0.004)	0.80 typ (0.031 typ)

Code	L	W	T	P	c	d	e (top)	e (bottom)
Dim.	6.40±0.20 (0.252±0.008)	1.60±0.20 (0.063±0.008)	0.60±0.10 (0.024±0.004)	0.80 typ (0.031 typ)	0.30±0.20 (0.012±0.008)	0.40±0.15 (0.016±0.006)	0.50±0.10 (0.020±0.004)	0.40±0.15 (0.016±0.006)

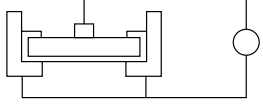
Detailed specifications are available on request.

# Chip Resistor Arrays



## CR, CJ, CRA, CRB, CRC Series - Test Conditions

### ELECTRICAL CHARACTERISTICS

Item	Standard		Test Conditions												
	Resistor	Jumper	Resistor	Jumper											
<b>DC Resistance</b>	Within Initial Tolerance		Power Condition A (20°C, 65% RH)												
<b>Temperature Characteristics</b>	<table border="1"> <thead> <tr> <th>Resistance (Ω)</th> <th>TCR (ppm/°C)</th> </tr> </thead> <tbody> <tr> <td><sup>*</sup>D, F 10 ≤ R ≤ 1M</td> <td>-100 to +100</td> </tr> <tr> <td>J, CR05 = F R &lt; 10</td> <td>-100 to +600</td> </tr> <tr> <td>10 ≤ R ≤ 1M</td> <td>-250 to +250</td> </tr> <tr> <td>1M &lt; R</td> <td>-500 to +300</td> </tr> </tbody> </table>		Resistance (Ω)	TCR (ppm/°C)	<sup>*</sup> D, F 10 ≤ R ≤ 1M	-100 to +100	J, CR05 = F R < 10	-100 to +600	10 ≤ R ≤ 1M	-250 to +250	1M < R	-500 to +300	/	Test Temperature: 25, 125(°C) $\Delta R/R = R_2 - R_1 / R_1 \times 1 / T_2 - T_1 \times 10^6$ $\Delta R/R = \text{Temp. Coefficient (ppm/°C)}$ T <sub>1</sub> = 25(°C) T <sub>2</sub> = 125(°C) R <sub>1</sub> = T <sub>1</sub> Resistance at (Ω) R <sub>2</sub> = T <sub>2</sub> Resistance at (Ω)	/
	Resistance (Ω)	TCR (ppm/°C)													
<sup>*</sup> D, F 10 ≤ R ≤ 1M	-100 to +100														
J, CR05 = F R < 10	-100 to +600														
10 ≤ R ≤ 1M	-250 to +250														
1M < R	-500 to +300														
<b>Short-time Overload</b>	$\Delta R/R$ $\pm(2.0\% + 0.10\Omega)$ max. of the initial value	50mΩ max.	(1) Apply 2.0 x rated voltage for 5 sec. (2.5 x rated voltage for Arrays) (2) Wait 30 minutes (3) Measure resistance CR03 = 30V max. CR05 = 50V max. CR10 = 100V max. CR21 = 200V max. CR32 = 400V max. CRA3A, CRB3A, CRC3A = 100V max.	(1) 2A for 5 sec. (CJ03 = 1A) (2) Wait 30 minutes (3) Measure resistance											
<b>Intermittent Overload</b>	<b>Visual</b>	No evidence of mechanical damage intermittent overload		(1) Perform 10,000 voltage cycles as follows: ON (2.0 x rated voltage, 2.5 x for Arrays) 1 sec. OFF 25 sec. (2) Stabilization time 30 min. without loading (3) Measure resistance CR03 = 30V max. CR05 = 50V max. CR10 = 150V max. CR21 = 200V max. CR32 = 400V max. CRA, CRB, CRC = 100V max.	(1) Perform 10,000 current cycles as follows: ON (2A) 1 sec. OFF 25 sec. (2) Wait 30 minutes (3) Measure resistance CJ03 = 1A max.										
	<b>Visual</b>	No evidence of mechanical damage													
<b>Dielectric Withstanding Voltage</b>	No evidence of mechanical damage		Apply 500 VAC for 1 min. (CR10 300 VAC) (CR05, CRA3A, CRB3A, CRC3A 300 VAC/1 sec. CR03 50 VAC/min.)												
<b>Insulation Resistance</b>	<ul style="list-style-type: none"> <li>• CR03, CJ03 = 10<sup>8</sup>Ω min.</li> <li>• CR05, CJ05 = 10<sup>8</sup>Ω min.</li> <li>• CR10, CJ10 = 10<sup>9</sup>Ω min.</li> <li>• CR21, CJ21 = 10<sup>10</sup>Ω min.</li> <li>• CR32, CJ32 = 10<sup>12</sup>Ω min.</li> <li>• CRA3A, CRB3A, CRC3A = 10<sup>9</sup>Ω min.</li> </ul>		Apply 500V DC (CR05, CRA3A, CRB3A, CRC3A 100V DC CR03 50 VDC) 												

# Chip Resistor Arrays



## CR, CJ, CRA, CRB, CRC Series - Test Conditions

### MECHANICAL CHARACTERISTICS

Item		Standard		Test Conditions	
		Resistor	Jumper	Resistor	Jumper
Terminal Strength	$\Delta R/R$	$\pm(1\%+0.05\Omega)$ max. of the initial value	50m $\Omega$ max.	Apply the load as shown: Measure resistance during load application	
	Visual	No evidence of mechanical damage after loading			
Soldering Heat Resistance	$\Delta R/R$	$\pm(1\%+0.05\Omega)$ max. of the initial value	50m $\Omega$ max.	Immerse into molten solder at $260\pm 5^\circ\text{C}$ for $10\pm 1$ sec. Stabilize component at room temperature for 1 hr. Measure resistance.	
	Visual	No evidence of leaching			
Solderability		Coverage $\geq 95\%$ each termination end		Immerse in Rogin Flux for $2\pm 0.5$ sec. and in SN62 solder at $235\pm 5^\circ\text{C}$ for $2\pm 0.5$ sec.	
Anti-Vibration Test	$\Delta R/R$	$\pm(1\%+0.1\Omega)$ max. of the initial value	50m $\Omega$ max.	2 hrs. each in X, Y and Z axis. (TTL 6 hrs.) 10 to 55 Hz sweep in 1 min. at 1.5mm amplitude.	
	Visual	No evidence of mechanical damage			
Solvent Resistance	$\Delta R/R$	$\pm(0.5\%+0.05\Omega)$ max. of the initial value	50m $\Omega$ max.	Immerse in static state butyl acetate at $20^\circ\text{C}$ to $25^\circ\text{C}$ for $30\pm 5$ sec. Stabilize component at room temperature for 30 min. then measure value.	
	Visual	No evidence of mechanical damage			

### ENVIRONMENTAL CHARACTERISTICS

Item		Standard		Test Conditions	
		Resistor	Jumper	Resistor	Jumper
Temperature Cycle	$\Delta R/R$	$\pm(1\%+0.05\Omega)$ max. of the initial value	50m $\Omega$ max.	(1) Run 5 cycles as follows: $-55\pm 3^\circ\text{C}$ for 30 min. $125\pm 3^\circ\text{C}$ for 30 min. Room temp. for 10-15 min. (2) Stabilize component at room temperature for 1 hr. then measure value.	
	Visual	No evidence of mechanical damage			
Low Temperature Storage	$\Delta R/R$	$\pm(2\%+0.1\Omega)$ max. of the initial value	50m $\Omega$ max.	(1) Dwell in $-55^\circ\text{C}$ chamber without loading for $1000^{+48}$ hrs. (2) Stabilize component at room temperature for 1 hr. then measure value.	
	Visual	No evidence of mechanical damage			
High Temperature Storage	$\Delta R/R$	$\pm(3\%+0.1\Omega)$ max. of the initial value	50m $\Omega$ max.	(1) Dwell in $125^\circ\text{C}$ chamber without loading for $1000^{+48}$ hrs. (2) Stabilize component at room temperature for 1 hr. then measure value.	
	Visual	No evidence of mechanical damage			
Moisture Resistance	$\Delta R/R$	$\pm(3\%+0.1\Omega)$ max. of the initial value	50m $\Omega$ max.	(1) Dwell in temp.: $65^\circ\text{C}$ RH90 to 95% RH chamber without loading for $1000^{+48}$ hrs. (2) Stabilize component at room temperature for 1 hr. then measure value.	
	Visual	No evidence of mechanical damage			
Life Test	$\Delta R/R$	$\pm(3\%+0.1\Omega)$ max. of the initial value	50m $\Omega$ max.	(1) Temp.: $70\pm 3^\circ\text{C}$ Voltage: (rated voltage) on 90 min. off 30 min. Duration: $1000^{+48}$ hrs. (2) Stabilize component at room temperature for 1 hr. then measure value.	
	Visual	No evidence of mechanical damage			
Loading Life in Moisture	$\Delta R/R$	$\pm(3\%+0.1\Omega)$ max. of the initial value	50m $\Omega$ max.	(1) Temp.: $40\pm 2^\circ\text{C}$ RH: 90-95% Voltage Cycle: on 90 min. (rated voltage) off 30 min. Duration: $1000^{+48}$ hrs. (2) Stabilize component at room temperature for 1 hr. then measure value.	
	Visual	No evidence of mechanical damage			

# Packaging of Chip Component

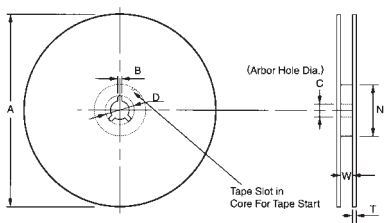


## Automatic Insertion Packaging

### TAPE AND REEL

#### REEL DIMENSIONS

millimeters (inches)

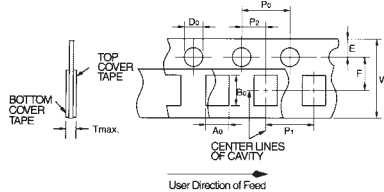


Tape Size	A Max.	B Min.	C	D Min.	N Min.	W	T Max.
8mm	178 (7)	1.50 (0.059)	13.0±0.50 (0.512±0.020)	20.2 (0.795)	50 (1.969)	10.0±1.50 (0.394±0.059)	2.50 (0.098)
	260 (10)						

Metric dimensions will govern.  
English measurements rounded and for reference only.

millimeters (inches)

#### PUNCHED TAPE CONFIGURATION 8MM TAPE ONLY

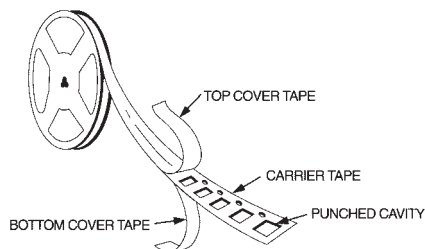


Tape Size	D <sub>0</sub>	E	P <sub>0</sub>	P <sub>2</sub>	W	F
8mm	1.50 <sup>+0.10</sup> / <sub>-0.004</sub> (0.059 <sup>+0.004</sup> / <sub>-0.000</sub> )	1.75±0.10 (0.069±0.004)	4.0±0.10 (0.157±0.004)	2.00±0.05 (0.079±0.002)	8.00±0.20 (0.135±0.008)	3.50±0.05 (0.138±0.002)

#### VARIABLE DIMENSIONS

Style	P <sub>1</sub>	A <sub>0</sub>	B <sub>0</sub>	T max.
CR/CJ03 CR/CJ05	2.00±0.10 (0.079±0.004)	0.65±0.10 (0.026±0.004)	1.15±0.10 (0.045±0.004)	0.60 (0.024)
CR/CJ/FR10	4.00±0.10 (0.157±0.004) or 2.00±0.10 (0.079±0.004)	1.10±0.20 (0.043±0.008)	1.90±0.20 (0.075±0.008)	1.10 (0.043)
CR/CJ/FR21	4.00±0.10 (0.157±0.004)	1.65±0.20 (0.065±0.008)	2.40±0.20 (0.094±0.008)	
CR/CJ/FR32		2.00±0.20 (0.079±0.008)	3.60±0.20 (0.142±0.008)	
CRB1A		1.90±0.20 (0.075±0.008)	1.90±0.20 (0.075±0.008)	
CRA3A CRB3A CRC3A		2.00±0.20 (0.079±0.008)	3.60±0.20 (0.142±0.008)	
CRB2A		2.00±0.10 (0.079±0.004)	1.25±0.20 (0.049±0.008)	

#### PUNCHED CARRIER



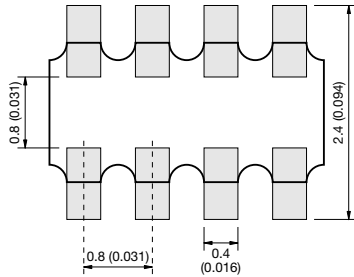
# Recommended Land Patterns



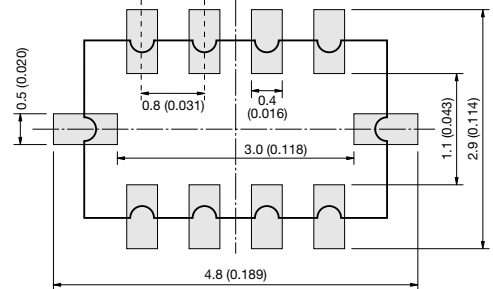
RECOMMENDED LAND PATTERNS IS REFERRED THE FOLLOWING FOR EXAMPLE

millimeters (inches)

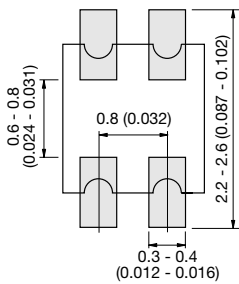
**CRA3A4E Series**



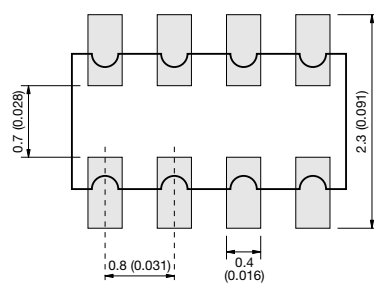
**RNA4A8E Series**



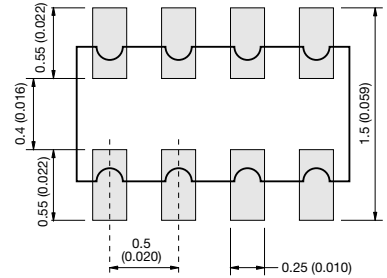
**CRB1A2E Series**



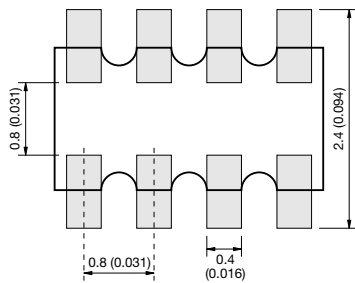
**CRB3A4E Series**



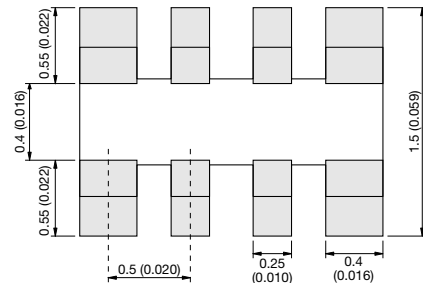
**CRB2A4E Series**



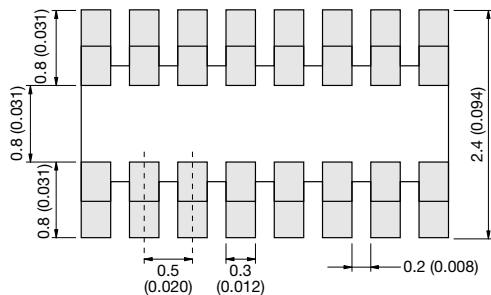
**CRC3A4E Series**



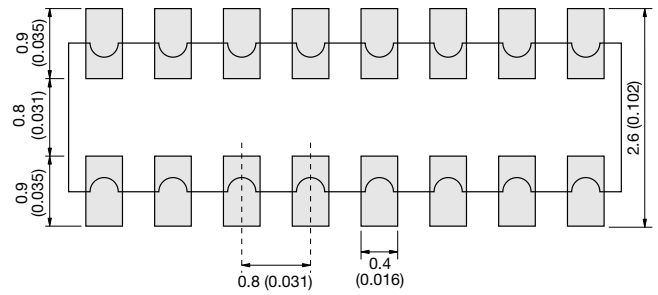
**CRC2A4E Series**



**CRC4A8E Series**



**CRB6A8E Series**



## SAMPLE KIT PART NUMBERS

Part Number	Description
<b>CRJ-E6-Kit</b>	Combination 0603, 0805, 1206, 5% parts 21 values per case size 100 pcs. per value (approx.)
<b>CR05-E12-Kit</b>	0402, 5% parts 63 values 100 pcs. per value
<b>CR10J-E12-Kit</b>	0603, 5% parts 63 values 100 pcs. per value (approx.)
<b>CR21J-E12-Kit</b>	0805, 5% parts 63 values 100 pcs. per value (approx.)
<b>CR32J-E12-Kit</b>	1206, 5% parts 63 values 100 pcs. per value (approx.)
<b>CR05F-E24-Kit</b>	0402, 1% parts 63 values 100 pcs. per value
<b>CR10F-E24-Kit</b>	0603, 1% parts 63 values 100 pcs. per value
<b>CR-ARRAY-E6-Kit</b>	Arrays, Various styles, CRA, CRB, CRC, RNA, 5% 13 values per style (approx.) 20 pcs. per value